Application/Control No. Applicant(s)/Patent Under Reexamination 10/643,934 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Thoi V. Duong 2871 **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code Name MM-YYYY US-6,507,385 B1 01-2003 Nishiyama et al. Α 349/156 US-6,275,280 B1 08-2001 В Kajita et al. 349/155 US-С D US-US-E US-F US-G US-US-١ US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Country Code-Number-Kind Code Name Classification MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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